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				Application Number	Not Yet Assigned U 660, T		
IN.	<b>IFORMATIO</b>	N DI	SCLOSURE	Filing Date	Concurrently Herewith		
S	STATEMENT BY APPLICANT			First Named Inventor	Richard A. Haight		
_				Art Unit	N/A		
	(Use as many sheets as necessary)			Examiner Name	Not Yet Assigned		
Sheet	1	of	1	Attorney Docket Number	20140-00303-US1		

U.S. PATENT DOCUMENTS						
Examiner Initials*	Cite No.'	Document Number Publication C		Name of Patentee or	Pages, Columns, Lines, Where	
		Number-Kind Code <sup>2</sup> (if known)	MM-DD-YYYY	Applicant of Cited Document	Relevant Passages or Relevant Figures Appear	
650	AA	US-6333485	12/25/01	Haight et al.		
G54	AB	US-6190836	2/20/01	Grenon et al.		
GSV	AC	US-6165649	12/26/00	Grenon et al.		
GEE	AD	US-6156461	12/05/00	Grenon et al.		
6515	AE	US-6050907	04/18/00	Long		
GE GE	AF	US-5656186	08/12/97	Mourou et al.		

FOREIGN PATENT DOCUMENTS						
Examiner Initials*	Cite	Foreign Patent Document	Publication Date MM-DD-YYYY	Name of Patentee or	Pages, Columns, Lines,	
	No.'	Country Code <sup>3</sup> -Number <sup>4</sup> -Kind Code <sup>3</sup> (if known)		Applicant of Cited Document	Where Relevant Passages or Relevant Figures Appear	Τ <sup>6</sup>

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NON PATENT LITERATURE DOCUMENTS						
Examiner Initials	Cite No. <sup>1</sup>	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published.	T²			
GEE	CA	MARS2: An Advanced Femtosecond Laser Mask Repair Tool, A. Wagner, R. Haight, P. Longo, SPIE, 42, 457 (2002)				
698	СВ	Femtosecond Laser Mask Repair, A. Wagner, R. Haight, P. Longo, M. Schmidt, P. Flanigan, D. Thibault, Microlithog. World, 12, 6, 2003				
GA€	CC	Femtosecond Lasers Repair Photomasks, R. Haight, P. Longo, A. Wagner, Laser Focus World, May 2002				
SEE	CD	MARS: A Femtosecond Laser Mask Advanced Repair System in Manufacturing, R. Haight, D. Hayden, P. Longo, T. Neary, A. Wagner, J. Vac. Sci. Technol., B 17, 3137 (1999).				
GEE	CE	Implementation and Performance of a Femtosecond Laser Mask Repair System In Manufacturing, R. Haight, D. Hayden, P. Longo, T. Neary, A. Wagner, SPIE, 3546, 477, 1998.				

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Examiner Signature	Ocales	Ex Heolpy	& Eren	Date Considered	October 3, 2005
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